MOSPEC

MIG030N120H

1200V Silicon Carbide MOSFET

DESCRIPTION：
- Low gate charge
- Low Switching Losses
- Fast reverse recovery body diode
- Fast High frequency operation
- Tight variation of $R_{DS(on)}$ with temperature

V_{DS}	1200 V
I_D (Tc = 25°C)	108.4 A
$R_{DS(on)}$	30 mΩ

TYPICAL APPLICATIONS：
- Solar inverters
- EV Charge
- Switch mode power supplies
- Motor drives
- Energy Storage
- Uninterruptible power supplies (UPS)

HU3PAK

MAXIMUM RATINGS (at T_J = 25 °C, unless otherwise specified)

Characteristic	Condition	Symbol	Value	Unit
Drain-Source Voltage		V_{DSS}	1200	V
Gate-Source Voltage Recommend Drive Voltage	Max Transient Voltage,<1% duty cycle	V_{GSS} $V_{GS(OP)}$	-10/+22 -3/+18	V
Continuous Drain Current	V_{GS}=18V, Tc=25℃ V_{GS}=18V, Tc=110℃	I_D	108.4 78.4	A
Pulsed Drain Current	Pulse width tp limited by Tjmax, V_{GS} = 18V	$I_{D PULSE}$	160	A
Total power dissipation	Tc=25℃ Tc=110℃	P_{tot}	555 246	W
Operation Junction temperature		Tj	-55~+175	℃
Storage temperature		T_{STG}	-55~+150	℃
Soldering Temperature	1.6mm (0.063") from case for 10s	T_L	260	℃

THERMAL CHARACTERISTICS

Characteristic	Condition	Symbol	Typical	Unit
Thermal resistance, junction - case		$R_{th(j-C)}$	0.27	℃/W

ELECTRICAL CHARATERISTICS (at T_J = 25 °C, unless otherwise specified)

Characteristic	Symbol	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage VGS = 0V, ID = 100µA	$V_{(BR)DSS}$	1200			V
Zero Gate Voltage Drain Current VDS = 1200 V, VGS = 0 V Tj=25℃ VDS = 1200 V, VGS = 0 V Tj=175℃	I_{DSS}		0.1 10	100 100	uA
Gate-Source Leakage Current VGS = 22V, VDS = 0V VGS = -10V, VDS = 0V	I_{GSS}			100 100	nA
Gate-Source Threshold Voltage VDS = VGS, ID = 15mA Tj=25℃ VDS = VGS, ID = 15mA Tj=175℃	$V_{GS(th)}$	2	3.2 2.2	5	V
Drain-Source On-State Resistance VGS = 18V, ID = 40A Tj=25℃ VGS = 18V, ID = 40A Tj=175℃	$R_{DS(on)}$		26 43	45	mΩ
Transconductance ID = 30A Tj=25℃ ID = 30A Tj=175℃	G_{fs}		16.2 17.0		S
Internal Gate Resistance f=1MHz, VAC=25 mV	$R_{G(int)}$		1.72		Ω
Input capacitance f=1MHz, VAC=25 mV, VDS=800 V, VGS=0 V	C_{iss}		3505		pF
Output capacitance f =1MHz, VAC=25 mV, VDS=800 V, VGS=0 V	C_{oss}		232		pF
Reverse transfer capacitance f=1MHz, VAC=25 mV, VDS=800 V, VGS=0 V	C_{rss}		39		pF
C_{OSS} Stored Energy f=1MHz, VAC=25 mV, VDS=800 V, VGS=0 V	E_{oss}		161		uJ
Total Gate Charge VDD= 800V, ID= 30A,VGS= -3/18V, turn-on pulse	Q_G		243		nC

Characteristic	Symbol		Typ.		Unit
Gate to Source Charge VDD= 800V, ID= 30A,VGS= -3/18V, turn-on pulse	Q_{GS}		37		nC
Gate to Drain Charge VDD= 800V, ID= 30A,VGS= -3/18V, turn-on pulse	Q_{GD}		113		nC
Turn-on delay time VDD=800 V, ID=60A, VGS= -5/18V, RG($_{EXT}$)=4.7Ω L$_\sigma$ = 100uH, Body diode at VGS = -5V (inductive load)	td $_{(ON)}$		23.13		ns
Rise time VDD=800 V, ID=30A, VGS= -3/18V, RG($_{EXT}$)=4.7Ω L$_\sigma$ = 100uH, Body diode at VGS = -3V (inductive load)	tr		38.25		ns
Turn-off delay time VDD=800 V, ID=30A, VGS= -3/18V, RG($_{EXT}$)=4.7Ω L$_\sigma$ = 100uH, Body diode at VGS = -3V (inductive load)	td $_{(OFF)}$		59.94		ns
Fall time VDD=800 V, ID=30A, VGS= -3/18V, RG($_{EXT}$)=4.7Ω L$_\sigma$ = 100uH, Body diode at VGS = -3V (inductive load)	tf		24.3		ns
Turn-on Switching Energy VDD=800 V, ID=30A, VGS= -3/18V, RG($_{EXT}$)=4.7Ω L$_\sigma$ = 100uH, Body diode at VGS = -3V (inductive load)	E$_{(ON)}$		681.03		uJ
Turn-off Switching Energy VDD=800 V, ID=30A, VGS= -3/18V, RG($_{EXT}$)=4.7Ω L$_\sigma$ = 100uH, Body diode at VGS = -3V (inductive load)	E$_{(OFF)}$		248.22		uJ
Total Switching Energy VDD=800 V, ID=30A, VGS= -3/18V, RG($_{EXT}$)=4.7Ω L$_\sigma$ = 100uH, Body diode at VGS = -3V (inductive load)	E$_{(TOT)}$		929.25		uJ

Body Diode

ELECTRICAL CHARATERISTICS (at TJ = 25 °C, unless otherwise specified)

Characteristic	Symbol	Min.	Typ.	Max.	Unit
Diode Forward Voltage VGS = 0V, ISD = 25A Tj=25℃ VGS = 0V, ISD = 25A Tj=175℃	V_{SD}		3.79 3.36		V

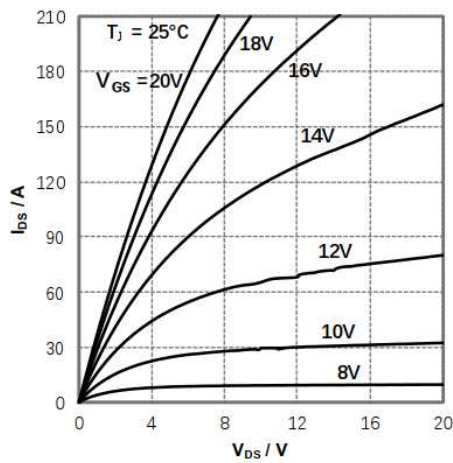| Continuous Diode Forward Current VGS = -3V, Tj=25℃ VGS = -3V, Tj=100℃	I$_{SD}$			93 53.4	A
Revers Recovery Time VDD=800 V, ID=30A, VGS= -3V, di/dt = 1000A/us	Trr		32		ns
Revers Recovery Charge VDD=800 V, ID=30A, VGS= -3V, di/dt = 1000A/us	Qrr		344		nC
Peak Revers Recovery Current VDD=800 V, ID=30A, VGS= -3V, di/dt = 1000A/us	I$_{rrm}$		18		A

Figure 1. Typical output characteristics (Tj=25℃)
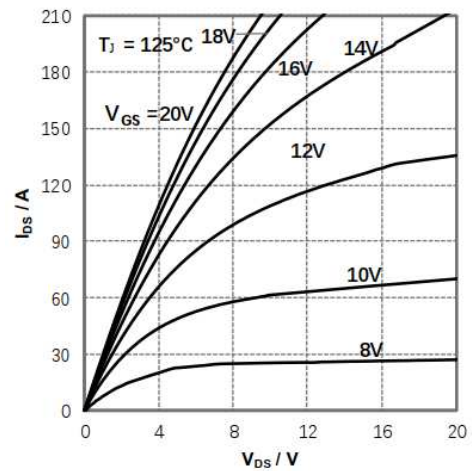
Figure 2. Typical output characteristics (Tj=125℃)
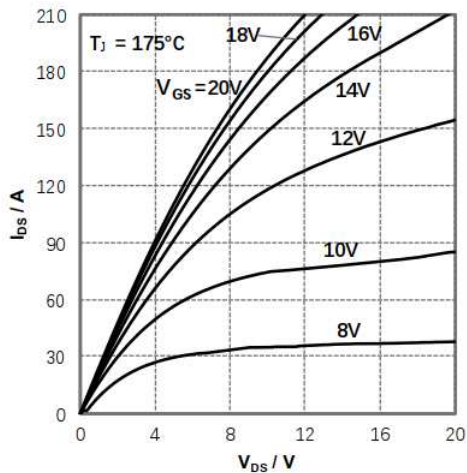
Figure 3. Typical output characteristics (Tj=175℃)
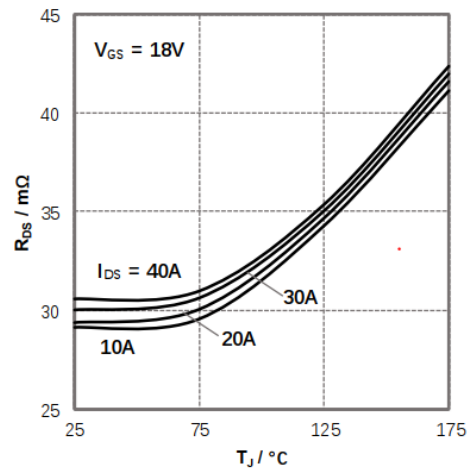
Figure 4. Typical On-Resistance vs. Temperature For Various Drain Current)

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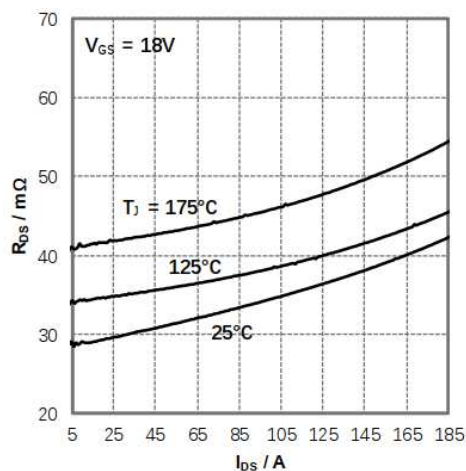
Figure 5. On-Resistance vs. Drain Current
For Various Temperature
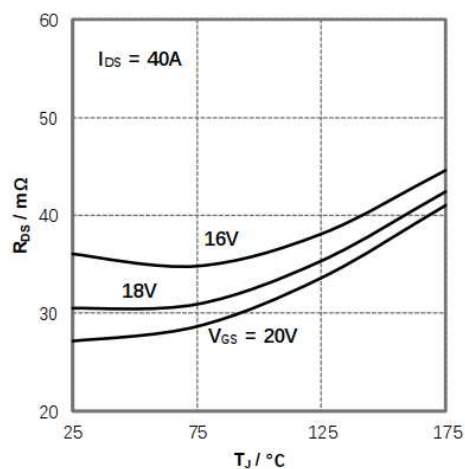
Figure 6. On-Resistance vs. Temperature
For Various Gate Voltage
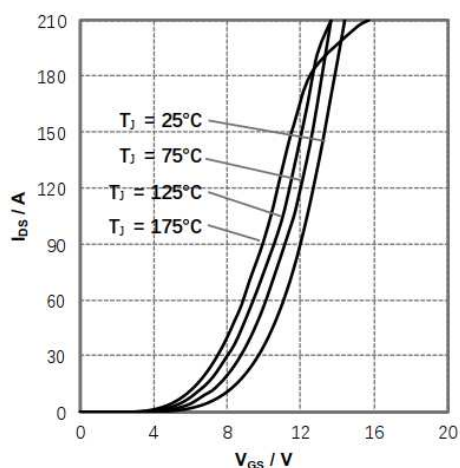
Figure 7. Transfer Characteristics
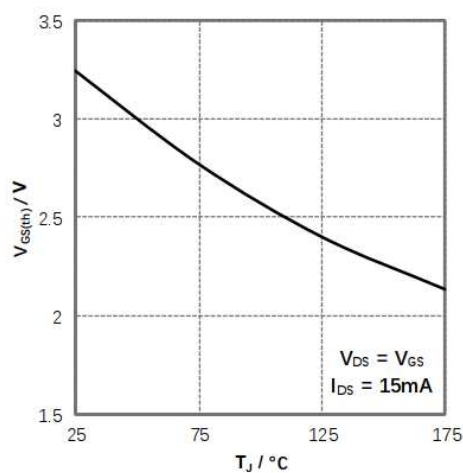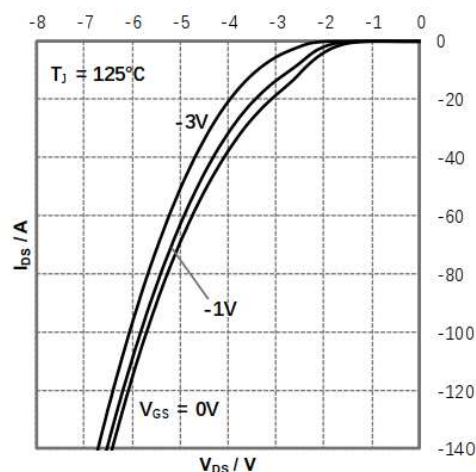
Figure 8. Threshold Voltage vs. Temperature
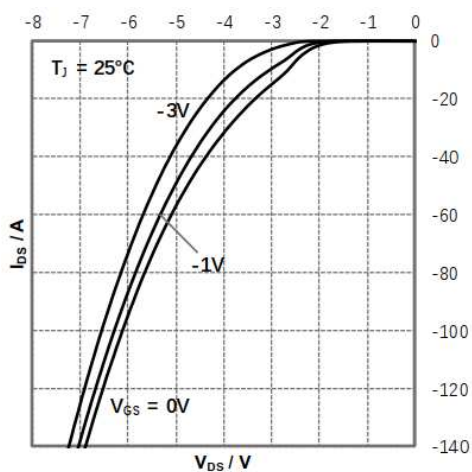
Figure 9. Body Diode Characteristics TJ=25℃
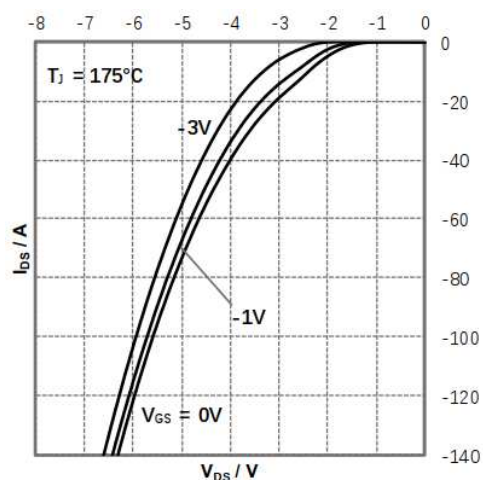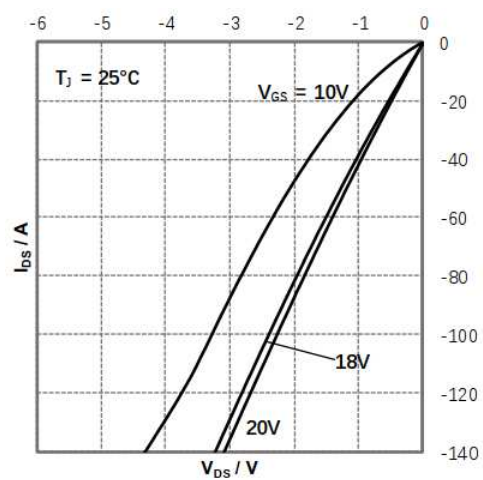
Figure 10. Body Diode Characteristics TJ=·125℃

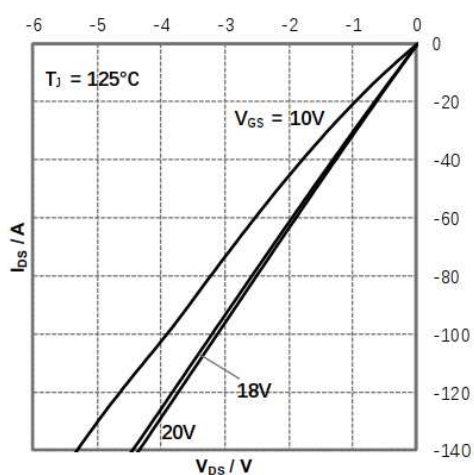Figure 11. Body Diode Characteristics TJ=·175℃

Figure 12. 3rd Quadrant Characteristics TJ=·25℃

Figure 13. 3rd Quadrant Characteristics TJ=·125℃
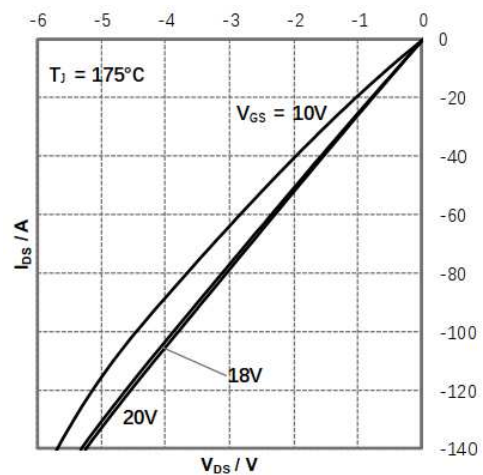
Figure 14. 3rd Quadrant Characteristics TJ=·175℃
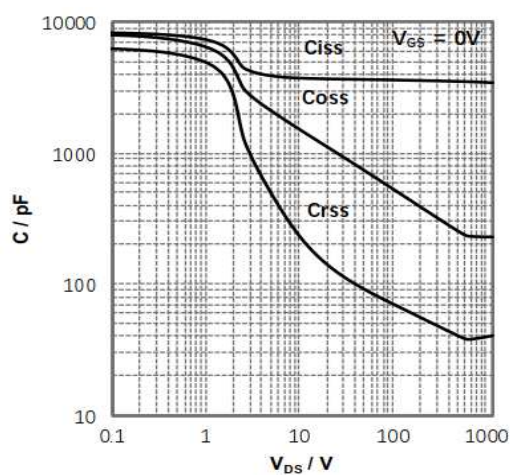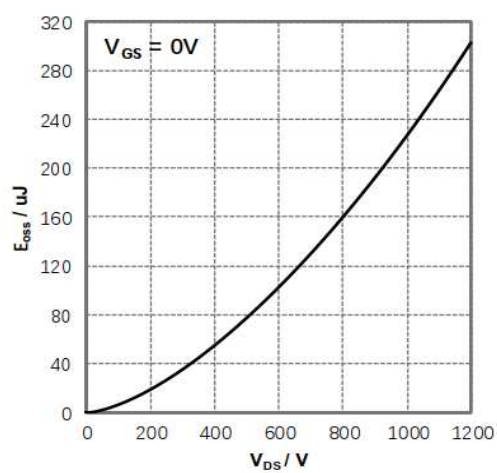
Figure 15. Capacitances vs. Drain-Source Voltage

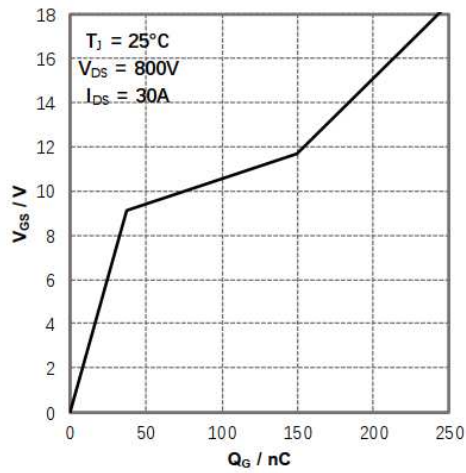Figure 16. Output Capacitor Stored Energy
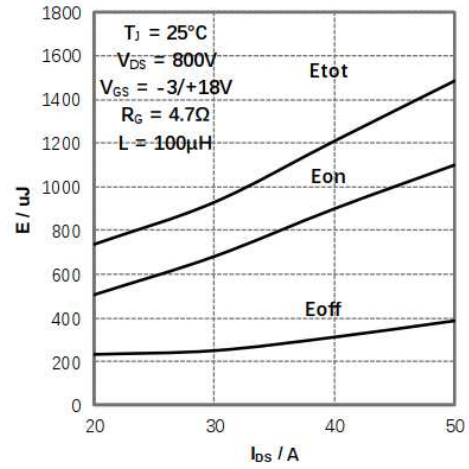
Figure 17. Gate Charge Characteristics

Figure 18. Switching Energy vs. Drain Current
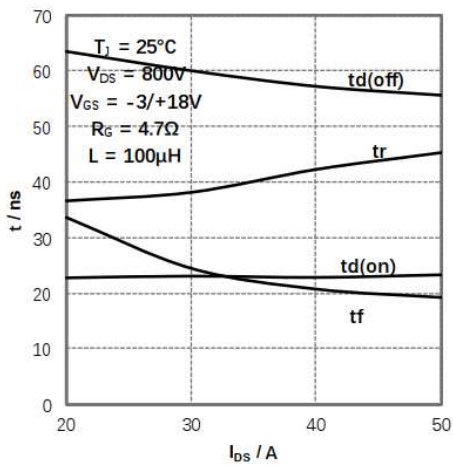

Figure 19. Switching Time vs. Drain Current
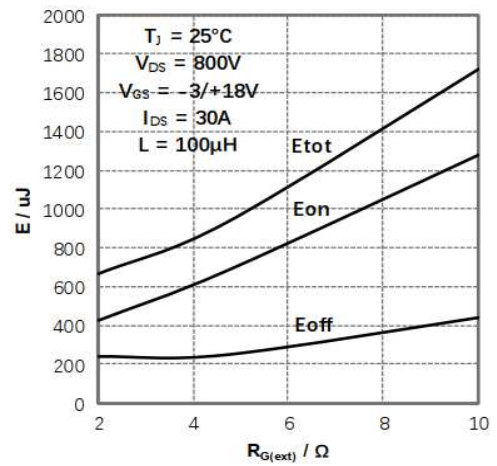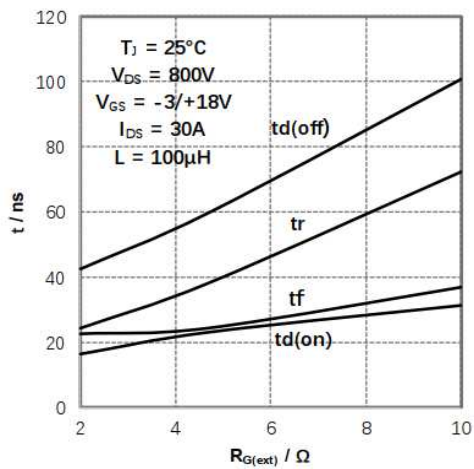

Figure 20. Switching Energy vs. RG(ext)
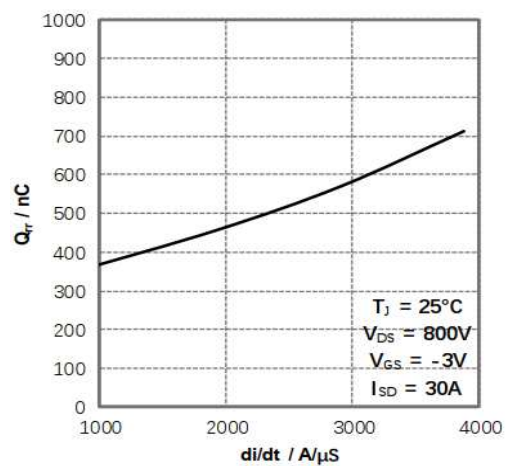

Figure 21. Switching Time vs. RG(ext)

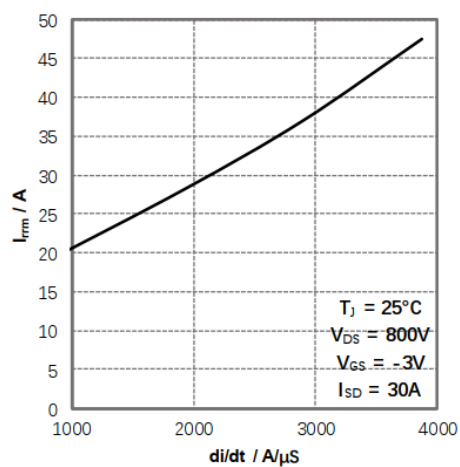Figure 22. Reverse Recovery Charge vs. di/dt
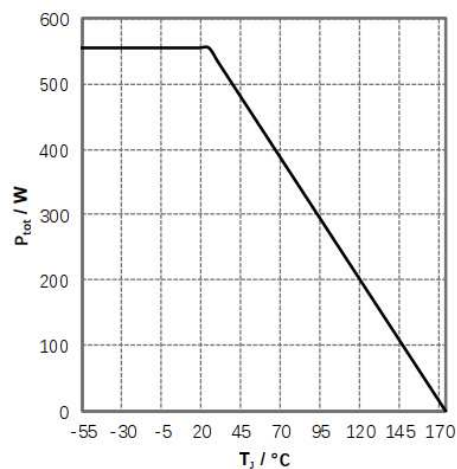
Figure 23. Reverse Recovery Current vs. di/dt

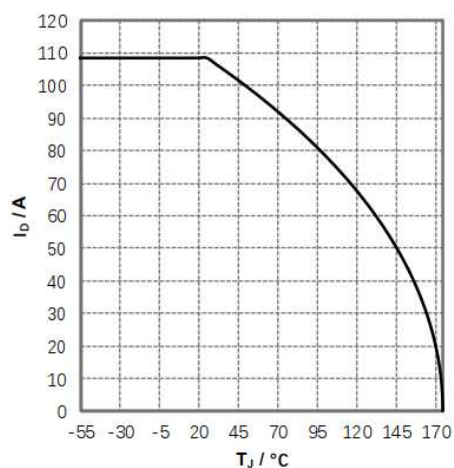Figure 24. Power Dissipation Derating

Figure 25. Continuous Drian Current Derating
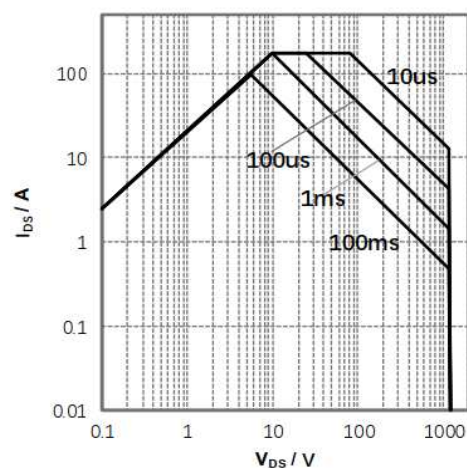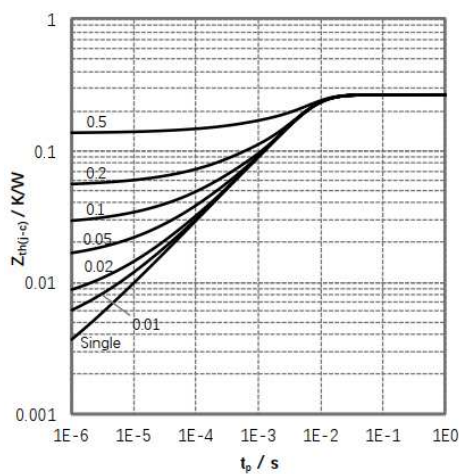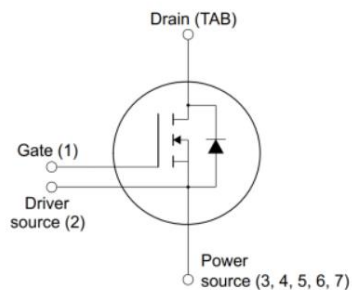

Figure 26. Safe Operating Area

Figure 27. Transient Thermal Impedance
(Junction-Case)

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· Circuit diagram

Drain (TAB)

Gate (1)

Driver
source (2)

Power
source (3, 4, 5, 6, 7)

· Package outlines : Dimensions in (mm)
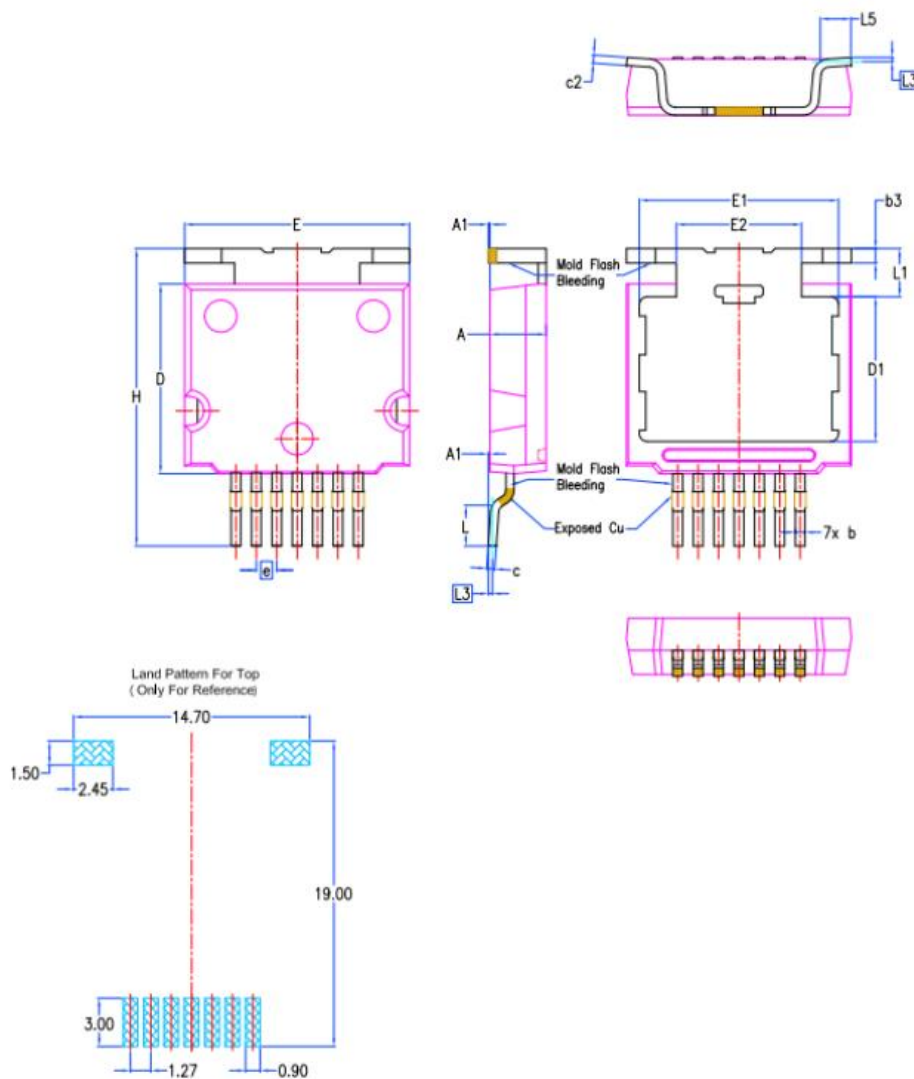
SYMBOL	DIMENSIONS		
	MIN.	NOM.	MAX.
A	3.40	3.50	3.60
A1	0.00	0.10	0.25
b	0.50	0.60	0.70
b3	0.80	0.90	1.00
c	0.40	0.50	0.60
c2	0.40	0.50	0.60
D	11.70	11.80	11.90
D1	8.80	9.00	9.10
E	13.90	14.00	14.10
E1	12.30	12.40	12.50
E2	7.75	7.80	7.85
e	1.27 BSC		
H	18.00	18.50	19.00
L	2.30	2.50	2.75
L1	—	3.05	—
L3	—	0.26	—
L5	1.70	1.90	2.15

Land Pattern For Top
(Only For Reference)
14.70
1.50
2.45
19.00
3.00
1.27
0.90

Mold Flash
Bleeding

Mold Flash
Bleeding

Exposed Cu

7x b

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